



SOT-723 Plastic-Encapsulate Diodes

CESDLC5V0AT7

Low Capacitance for ESD Protection

DESCRIPTION

The CESDLC5V0AT7 is designed to protect voltage sensitive components from ESD. Excellent clamping capability, low leakage, and fast response time provide best in class protection on designs that are exposed to ESD. Because of its small size, it is suited for use in cellular phones, MP3 players, digital cameras and many other portable applications where board space is at a premium.

FEATURES

- Two Separate Unidirectional Configurations for Protection
- Low Leakage Current $<0.1\mu\text{A}$ @ 5 Volts
- Small Package
- Low Capacitance
- Complies to USB 1.1 Low Speed & Full Speed Specifications
- These are Pb-Free Devices

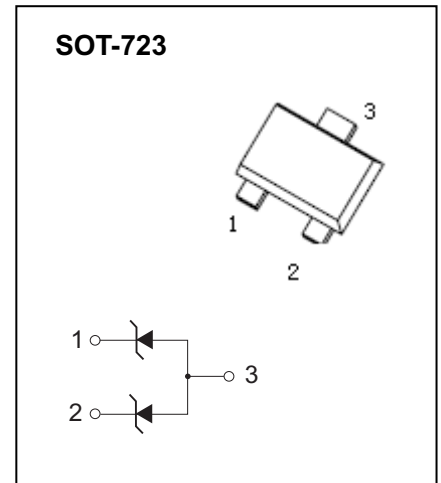
BENEFITS

- Protect Two Lines Against Transient Voltage Conditions
- Minimize Power Consumption of the System
- Minimize PCB Board Space

TYPICAL APPLICATIONS

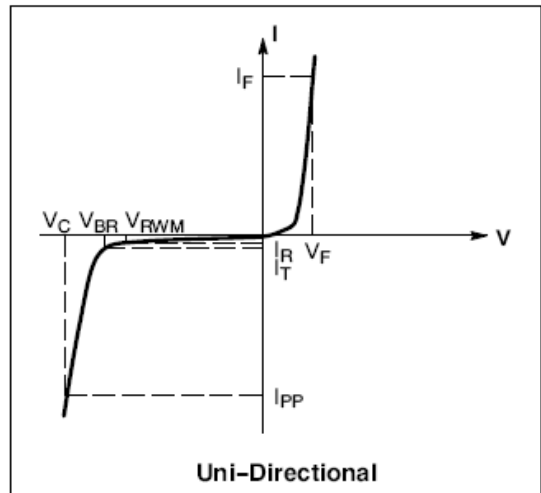
- Instrumentation Equipment
- Serial and Parallel Ports
- Microprocessor Based Equipment
- Notebooks, Desktops, Servers
- Cellular and Portable Equipment

MARKING:5C



ELECTRICAL CHARACTERISTICS (Ta = 25°C unless otherwise noted)

Symbol	Parameter
I_{PP}	Maximum Reverse Peak Pulse Current (Note 1)
V_C	Clamping Voltage @ I_{PP}
V_{RWM}	Working Peak Reverse Voltage
I_R	Maximum Reverse Leakage Current @ V_{RWM}
V_{BR}	Breakdown Voltage @ I_T
I_T	Test Current



Maximum Ratings (Ta=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Steady State Power -- 1 Diode (Note 2)	P_D	150	mW
Thermal Resistance Junction-to-Ambient Above 25 °C, derate	$R_{\theta JA}$	833	°C/W
Maximum Junction Temperature	T_j	150	°C
Operating Junction and Storage Temperature Range	T_j, T_{stg}	-55 ~ +150	°C
Lead Solder Temperature (10 Seconds Duration)	T_L	260	°C

Stresses exceeding maximum ratings may damage the device. Maximum ratings are stress ratings only. Functional operation above the recommended. Operating conditions is not implied. Extended exposure to stresses above the recommended operating conditions may affect device reliability.

ELECTRICAL CHARACTERISTICS (Ta= 25°C unless otherwise noted, $V_F = 0.9$ V Max. @ $I_F = 10$ mA for all types)

Device	Device Marking	Breakdown voltage V_{BR} @ 1mA(Volts)			Leakage current I_{RM} @ V_{RM}		V_C Max @ I_{PP}		Capacitance @ $V_R=0$ V Bias (pF) (Note 3)	Capacitance @ $V_R=3$ V Bias (pF) (Note 3)
		Min	Mon	Max	V_{RWM}	I_{RWM} (μ A)	V_C (V)	I_{PP} (A)	Max	Max
CESDLC5V0AT7	5C	6.1	6.7	7.2	5.0	0.1	11	2	13	9

1. Non-repetitive current per Figure 1.
2. Only 1 diode under power. For all 2 diodes under power, P_D will be 50%. Mounted on FR-4 board with min pad.
3. Capacitance of one diode at $f = 1$ MHz, $T_a = 25^\circ$ C